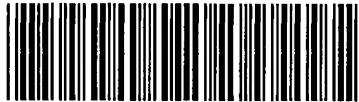


Search Notes



Application/Control No.

10/643,319

Examiner

Simon J. Oh

**Applicant(s)/Patent under
Reexamination**

RUFF ET AL.

Art Unit

1618

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner